

MOS FIELD EFFECT TRANSISTOR

2SK2157

N-CHANNEL MOS FET FOR HIGH-SPEED SWITCHING

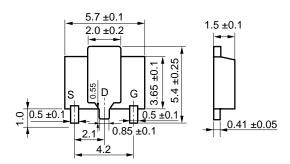
The 2SK2157 is a N-channel MOS FET of a vertical type and is a switching element that can be directly driven by the output of an IC operating at 5 V. This product has a low ON resistance and superb switching characteristics and is ideal for driving the actuators and DC/DC converters.

FEATURES

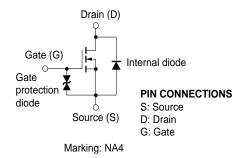
- New package intermediate between small-signal and power models
- · Can be directly driven by output of 5-V IC
- · Low ON resistance

 $\begin{aligned} &R_{DS(on)} \leq 0.15~\Omega &\text{@VGS} = 4~\text{V, ID} = 2.5~\text{A} \\ &R_{DS(on)} \leq 0.10~\Omega &\text{@VGS} = 10~\text{V, ID} = 2.5~\text{A} \end{aligned}$

PACKAGE DIMENSIONS (in mm)



EQUIVALENT CIRCUIT



ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

PARAMETER	SYMBOL	TEST CONDITIONS	RATING	UNIT
Drain to Source Voltage	VDSS	Vgs = 0	30	V
Gate to Source Voltage	Vgss	V _{DS} = 0	±20	٧
Drain Current (DC)	I _{D(DC)}		±5.0	А
Drain Current (Pulse)	ID(pulse)	PW ≤ 10 ms, Duty cycle ≤ 50 %	±10.0	А
Total Power Dissipation	Рт	$7.5~\text{cm}^2 \times 0.7~\text{mm}$, ceramic substrate used	2.0	W
Channel Temperature	Tch		150	°C
Storage Temperature	T _{stg}		-55 to +150	°C

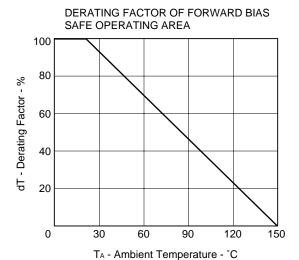


ELECTRICAL CHARACTERISTICS (TA = 25 °C)

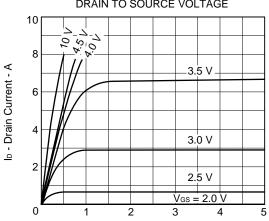
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Cut-Off Current	IDSS	V _{DS} = 30 V, V _{GS} = 0			1.0	μΑ
Gate Leakage Current	Igss	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0$			±10	μΑ
Gate Cut-Off Voltage	Vgs(off)	V _{DS} = 10 V, I _D = 1 mA	1.5	1.9	2.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 2.5 A	2.0			S
Drain to Source On-State Resistance	RDS(on)1	Vgs = 4 V, ID =2.5 A		0.09	0.15	Ω
Drain to Source On-State Resistance	RDS(on)2	Vgs = 10 V, ID = 2.5 A		0.06	0.10	Ω
Input Capacitance	Ciss	V _{DS} = 10 V, V _{GS} = 0,		650		pF
Output Capacitance	Coss	f = 1.0 MHz		400		pF
Reverse Transfer Capacitance	Crss			120		pF
Turn-On Delay Time	td(on)	V _{DD} = 10 V, I _D = 2.5 A		85		ns
Rise Time	tr	$V_{GS(on)}$ = 10 V, R_G = 10 Ω		450		ns
Turn-Off Delay Time	td(off)	$R_L = 4 \Omega$		285		ns
Fall Time	tr			315		ns

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TYPICAL CHARACTERISTICS (TA = 25 °C)

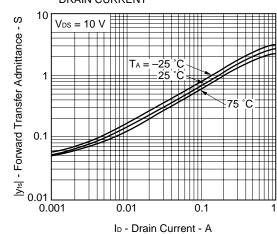




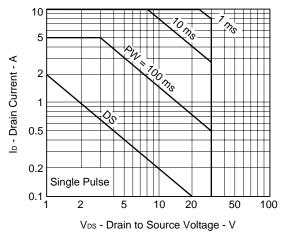


V_{DS} - Drain to Source Voltate -V

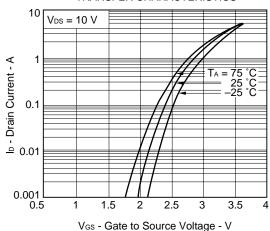
FORWARD TRANSFER ADMITTANCE vs. **DRAIN CURRENT**



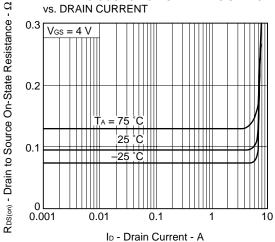
FORWARD BIAS SAFE OPERATING AREA



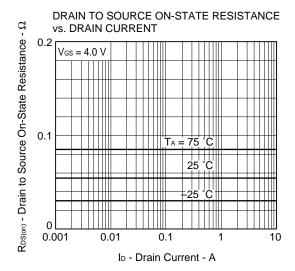
TRANSFER CHARACTERISTICS

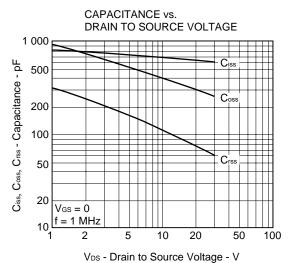


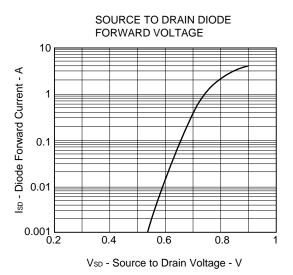
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

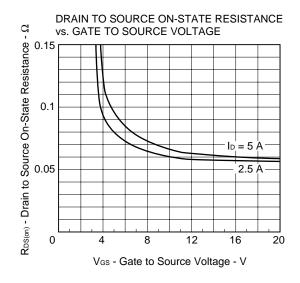


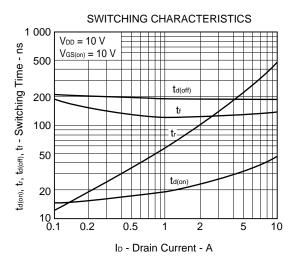














REFERENCE

Document Name	Document No.		
NEC semiconductor device reliability/quality control system	TEI-1202		
Quality grade on NEC semiconductor devices	IEI-1209		
Semiconductor device mounting technology manual	C10535E		
Guide to quality assurance for semiconductor devices	MEI-1202		
Semiconductor selection guide	X10679E		

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Anti-radioactive design is not implemented in this product.

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